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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Active
Number of LABs/CLBs	3125
Number of Logic Elements/Cells	50000
Total RAM Bits	1677312
Number of I/O	500
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	672-BGA
Supplier Device Package	672-FBGA (27x27)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/intel/10m50dcf672i7g">https://www.e-xfl.com/product-detail/intel/10m50dcf672i7g</a>



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## Recommended Operating Conditions

**Table 8. Recommended Operating Conditions for Intel MAX 10 Devices**

Symbol	Parameter	Condition	Min	Max	Unit
V <sub>I</sub>	DC input voltage	—	-0.5	3.6	V
V <sub>O</sub>	Output voltage for I/O pins	—	0	V <sub>CCIO</sub>	V
T <sub>J</sub>	Operating junction temperature	Commercial	0	85	°C
		Industrial	-40 <sup>(6)</sup>	100	°C
		Automotive	-40 <sup>(6)</sup>	125	°C
t <sub>RAMP</sub>	Power supply ramp time	—	(7)	10	ms
I <sub>Diode</sub>	Magnitude of DC current across PCI* clamp diode when enabled	—	—	10	mA

## Programming/Erasures Specifications

**Table 9. Programming/Erasures Specifications for Intel MAX 10 Devices**

This table shows the programming cycles and data retention duration of the user flash memory (UFM) and configuration flash memory (CFM) blocks.

For more information about data retention duration with 10,000 programming cycles for automotive temperature devices, contact your Intel quality representative.

Erase and reprogram cycles (E/P) <sup>(8)</sup> (Cycles/page)	Temperature (°C)	Data retention duration (Years)
10,000	85	20
10,000	100	10

(6) -40°C is only applicable to Start of Test, when the device is powered-on. The device does not stay at the minimum junction temperature for a long time.

(7) There is no absolute minimum value for the ramp time requirement. Intel characterized the minimum ramp time at 200 µs.

(8) The number of E/P cycles applies to the smallest possible flash block that can be erased or programmed in each Intel MAX 10 device. Each Intel MAX 10 device has multiple flash pages per device.



**Table 11. ADC\_VREF Pin Leakage Current for Intel MAX 10 Devices**

Symbol	Parameter	Condition	Min	Max	Unit
I <sub>adc_vref</sub>	ADC_VREF pin leakage current	Single supply mode	—	10	µA
		Dual supply mode	—	20	µA

#### Bus Hold Parameters

Bus hold retains the last valid logic state after the source driving it either enters the high impedance state or is removed. Each I/O pin has an option to enable bus hold in user mode. Bus hold is always disabled in configuration mode.

**Table 12. Bus Hold Parameters for Intel MAX 10 Devices**

Parameter	Condition	V <sub>CCIO</sub> (V)												Unit	
		1.2		1.5		1.8		2.5		3.0		3.3			
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max		
Bus-hold low, sustaining current	V <sub>IN</sub> > V <sub>IL</sub> (maximum)	8	—	12	—	30	—	50	—	70	—	70	—	µA	
Bus-hold high, sustaining current	V <sub>IN</sub> < V <sub>IH</sub> (minimum)	-8	—	-12	—	-30	—	-50	—	-70	—	-70	—	µA	
Bus-hold low, overdrive current	0 V < V <sub>IN</sub> < V <sub>CCIO</sub>	—	125	—	175	—	200	—	300	—	500	—	500	µA	
Bus-hold high, overdrive current	0 V < V <sub>IN</sub> < V <sub>CCIO</sub>	—	-125	—	-175	—	-200	—	-300	—	-500	—	-500	µA	
Bus-hold trip point	—	0.3	0.9	0.375	1.125	0.68	1.07	0.7	1.7	0.8	2	0.8	2	V	

Figure 3. LVTTL/LVC MOS Input Standard Voltage Diagram

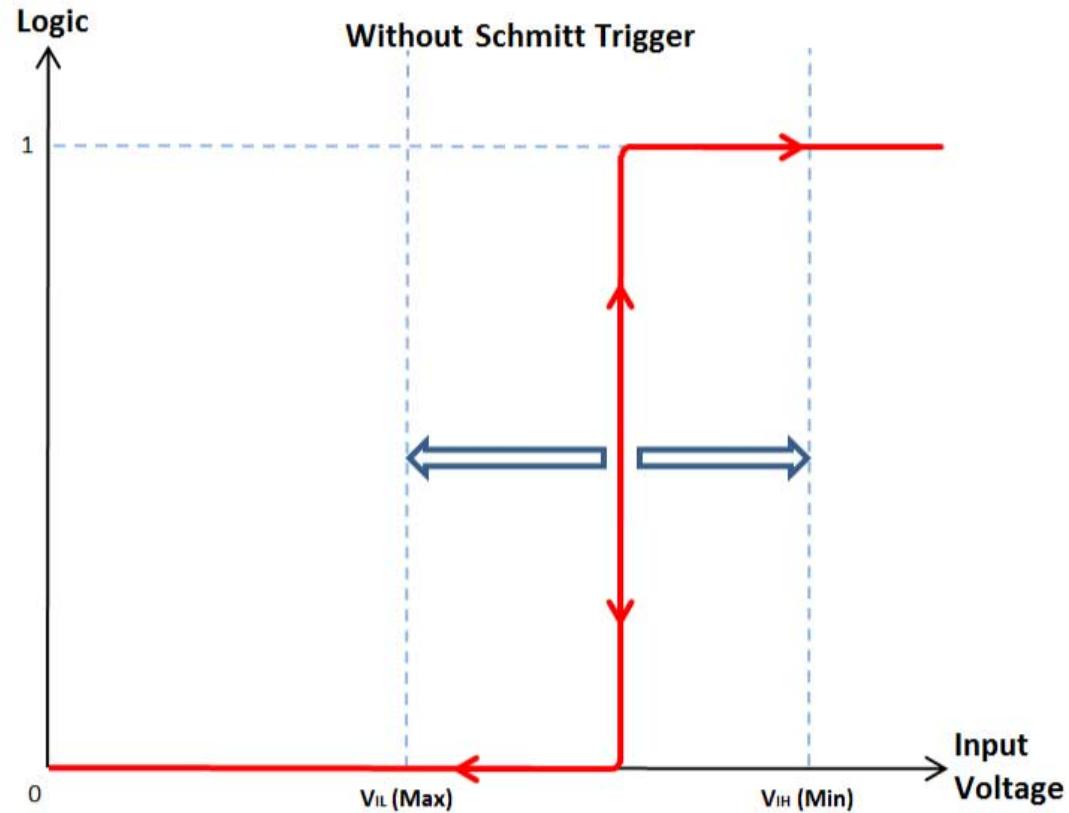
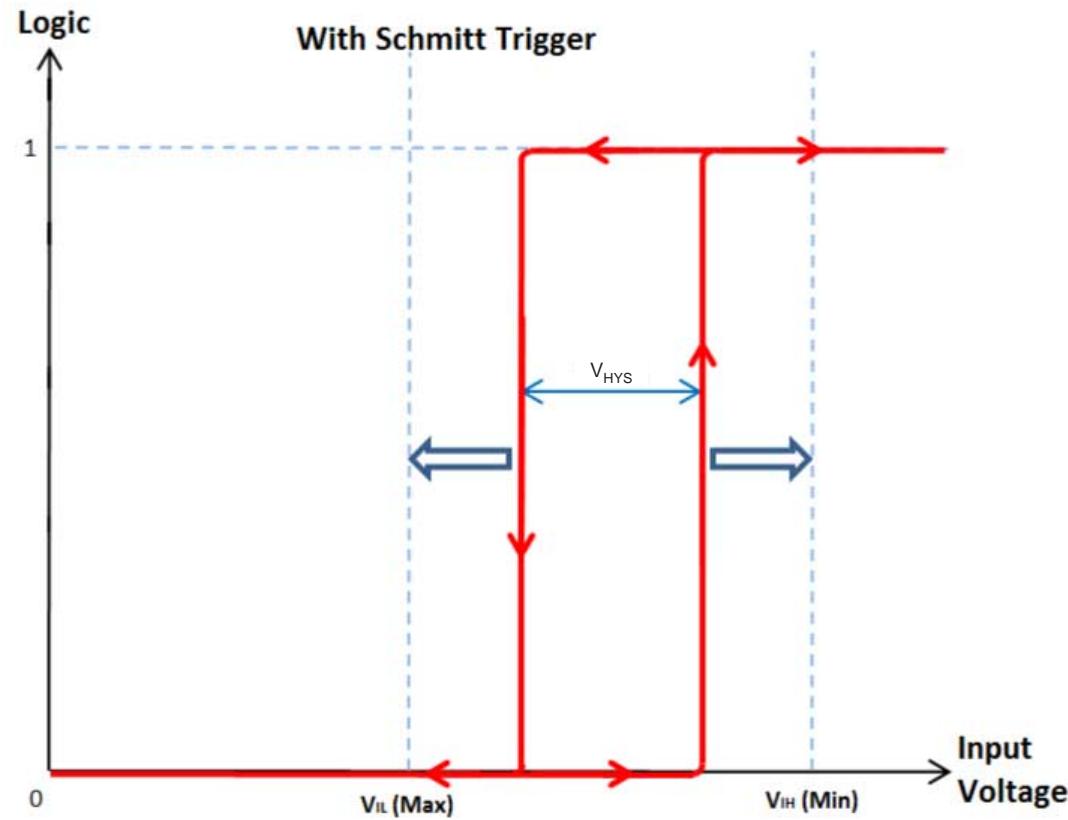


Figure 4. Schmitt Trigger Input Standard Voltage Diagram



### I/O Standards Specifications

Tables in this section list input voltage ( $V_{IH}$  and  $V_{IL}$ ), output voltage ( $V_{OH}$  and  $V_{OL}$ ), and current drive characteristics ( $I_{OH}$  and  $I_{OL}$ ) for various I/O standards supported by Intel MAX 10 devices.

For minimum voltage values, use the minimum  $V_{CCIO}$  values. For maximum voltage values, use the maximum  $V_{CCIO}$  values.

You must perform timing closure analysis to determine the maximum achievable frequency for general purpose I/O standards.



## Single-Ended SSTL, HSTL, and HSUL I/O Standards Signal Specifications

**Table 22. Single-Ended SSTL, HSTL, and HSUL I/O Standards Signal Specifications for Intel MAX 10 Devices**

To meet the  $I_{OL}$  and  $I_{OH}$  specifications, you must set the current strength settings accordingly. For example, to meet the SSTL-15 Class I specification (8 mA), you should set the current strength settings to 8 mA. Setting at lower current strength may not meet the  $I_{OL}$  and  $I_{OH}$  specifications in the datasheet.

I/O Standard	$V_{IL(DC)}$ (V)		$V_{IH(DC)}$ (V)		$V_{IL(AC)}$ (V)		$V_{IH(AC)}$ (V)		$V_{OL}$ (V)	$V_{OH}$ (V)	$I_{OL}$ (mA)	$I_{OH}$ (mA)
	Min	Max	Min	Max	Min	Max	Min	Max	Max	Min		
SSTL-2 Class I	—	$V_{REF} - 0.18$	$V_{REF} + 0.18$	—	—	$V_{REF} - 0.31$	$V_{REF} + 0.31$	—	$V_{TT} - 0.57$	$V_{TT} + 0.57$	8.1	-8.1
SSTL-2 Class II	—	$V_{REF} - 0.18$	$V_{REF} + 0.18$	—	—	$V_{REF} - 0.31$	$V_{REF} + 0.31$	—	$V_{TT} - 0.76$	$V_{TT} + 0.76$	16.4	-16.4
SSTL-18 Class I	—	$V_{REF} - 0.125$	$V_{REF} + 0.125$	—	—	$V_{REF} - 0.25$	$V_{REF} + 0.25$	—	$V_{TT} - 0.475$	$V_{TT} + 0.475$	6.7	-6.7
SSTL-18 Class II	—	$V_{REF} - 0.125$	$V_{REF} + 0.125$	—	—	$V_{REF} - 0.25$	$V_{REF} + 0.25$	—	0.28	$V_{CCIO} - 0.28$	13.4	-13.4
SSTL-15 Class I	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.175$	$V_{REF} + 0.175$	—	$0.2 \times V_{CCIO}$	$0.8 \times V_{CCIO}$	8	-8
SSTL-15 Class II	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.175$	$V_{REF} + 0.175$	—	$0.2 \times V_{CCIO}$	$0.8 \times V_{CCIO}$	16	-16
SSTL-135	—	$V_{REF} - 0.09$	$V_{REF} + 0.09$	—	—	$V_{REF} - 0.16$	$V_{REF} + 0.16$	—	$0.2 \times V_{CCIO}$	$0.8 \times V_{CCIO}$	—	—
HSTL-18 Class I	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.2$	$V_{REF} + 0.2$	—	0.4	$V_{CCIO} - 0.4$	8	-8
HSTL-18 Class II	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.2$	$V_{REF} + 0.2$	—	0.4	$V_{CCIO} - 0.4$	16	-16
HSTL-15 Class I	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.2$	$V_{REF} + 0.2$	—	0.4	$V_{CCIO} - 0.4$	8	-8
HSTL-15 Class II	—	$V_{REF} - 0.1$	$V_{REF} + 0.1$	—	—	$V_{REF} - 0.2$	$V_{REF} + 0.2$	—	0.4	$V_{CCIO} - 0.4$	16	-16

**continued...**



I/O Standard	V <sub>IL(DC)</sub> (V)		V <sub>IH(DC)</sub> (V)		V <sub>IL(AC)</sub> (V)		V <sub>IH(AC)</sub> (V)		V <sub>OL</sub> (V)	V <sub>OH</sub> (V)	I <sub>OL</sub> (mA)	I <sub>OH</sub> (mA)
	Min	Max	Min	Max	Min	Max	Min	Max	Max	Min		
HSTL-12 Class I	-0.15	V <sub>REF</sub> - 0.08	V <sub>REF</sub> + 0.08	V <sub>CCIO</sub> + 0.15	-0.24	V <sub>REF</sub> - 0.15	V <sub>REF</sub> + 0.15	V <sub>CCIO</sub> + 0.24	0.25 × V <sub>CCIO</sub>	0.75 × V <sub>CCIO</sub>	8	-8
HSTL-12 Class II	-0.15	V <sub>REF</sub> - 0.08	V <sub>REF</sub> + 0.08	V <sub>CCIO</sub> + 0.15	-0.24	V <sub>REF</sub> - 0.15	V <sub>REF</sub> + 0.15	V <sub>CCIO</sub> + 0.24	0.25 × V <sub>CCIO</sub>	0.75 × V <sub>CCIO</sub>	14	-14
HSUL-12	—	V <sub>REF</sub> - 0.13	V <sub>REF</sub> + 0.13	—	—	V <sub>REF</sub> - 0.22	V <sub>REF</sub> + 0.22	—	0.1 × V <sub>CCIO</sub>	0.9 × V <sub>CCIO</sub>	—	—

### Differential SSTL I/O Standards Specifications

Differential SSTL requires a V<sub>REF</sub> input.

**Table 23. Differential SSTL I/O Standards Specifications for Intel MAX 10 Devices**

I/O Standard	V <sub>CCIO</sub> (V)			V <sub>Swing(DC)</sub> (V)		V <sub>X(AC)</sub> (V)			V <sub>Swing(AC)</sub> (V)	
	Min	Typ	Max	Min	Max <sup>(17)</sup>	Min	Typ	Max	Min	Max
SSTL-2 Class I, II	2.375	2.5	2.625	0.36	V <sub>CCIO</sub>	V <sub>CCIO</sub> /2 - 0.2	—	V <sub>CCIO</sub> /2 + 0.2	0.7	V <sub>CCIO</sub>
SSTL-18 Class I, II	1.7	1.8	1.9	0.25	V <sub>CCIO</sub>	V <sub>CCIO</sub> /2 - 0.175	—	V <sub>CCIO</sub> /2 + 0.175	0.5	V <sub>CCIO</sub>
SSTL-15 Class I, II	1.425	1.5	1.575	0.2	—	V <sub>CCIO</sub> /2 - 0.15	—	V <sub>CCIO</sub> /2 + 0.15	2(V <sub>IH(AC)</sub> - V <sub>REF</sub> )	2(V <sub>IL(AC)</sub> - V <sub>REF</sub> )
SSTL-135	1.283	1.35	1.45	0.18	—	V <sub>REF</sub> - 0.135	0.5 × V <sub>CCIO</sub>	V <sub>REF</sub> + 0.135	2(V <sub>IH(AC)</sub> - V <sub>REF</sub> )	2(V <sub>IL(AC)</sub> - V <sub>REF</sub> )

### Differential HSTL and HSUL I/O Standards Specifications

Differential HSTL requires a V<sub>REF</sub> input.

<sup>(17)</sup> The maximum value for V<sub>SWING(DC)</sub> is not defined. However, each single-ended signal needs to be within the respective single-ended limits (V<sub>IH(DC)</sub> and V<sub>IL(DC)</sub>).



**Table 24. Differential HSTL and HSUL I/O Standards Specifications for Intel MAX 10 Devices**

I/O Standard	V <sub>CCIO</sub> (V)			V <sub>DIF(DC)</sub> (V)		V <sub>X(AC)</sub> (V)			V <sub>CM(DC)</sub> (V)			V <sub>DIF(AC)</sub> (V)
	Min	Typ	Max	Min	Max	Min	Typ	Max	Min	Typ	Max	Min
HSTL-18 Class I, II	1.71	1.8	1.89	0.2	—	0.85	—	0.95	0.85	—	0.95	0.4
HSTL-15 Class I, II	1.425	1.5	1.575	0.2	—	0.71	—	0.79	0.71	—	0.79	0.4
HSTL-12 Class I, II	1.14	1.2	1.26	0.16	V <sub>CCIO</sub>	0.48 × V <sub>CCIO</sub>	0.5 × V <sub>CCIO</sub>	0.52 × V <sub>CCIO</sub>	0.48 × V <sub>CCIO</sub>	0.5 × V <sub>CCIO</sub>	0.52 × V <sub>CCIO</sub>	0.3
HSUL-12	1.14	1.2	1.3	0.26	—	0.5 × V <sub>CCIO</sub> – 0.12	0.5 × V <sub>CCIO</sub>	0.5 × V <sub>CCIO</sub> + 0.12	0.4 × V <sub>CCIO</sub>	0.5 × V <sub>CCIO</sub>	0.6 × V <sub>CCIO</sub>	0.44

#### Differential I/O Standards Specifications

**Table 25. Differential I/O Standards Specifications for Intel MAX 10 Devices**

I/O Standard	V <sub>CCIO</sub> (V)			V <sub>ID</sub> (mV)		V <sub>ICM</sub> (V) <sup>(18)</sup>			V <sub>OD</sub> (mV) <sup>(19)(20)</sup>			V <sub>OS</sub> (V) <sup>(19)</sup>		
	Min	Typ	Max	Min	Max	Min	Condition	Max	Min	Typ	Max	Min	Typ	Max
LVPECL <sup>(21)</sup>	2.375	2.5	2.625	100	—	0.05	D <sub>MAX</sub> ≤ 500 Mbps	1.8	—	—	—	—	—	—
						0.55	500 Mbps ≤ D <sub>MAX</sub> ≤ 700 Mbps	1.8						
						1.05	D <sub>MAX</sub> > 700 Mbps	1.55						
LVDS	2.375	2.5	2.625	100	—	0.05	D <sub>MAX</sub> ≤ 500 Mbps	1.8	247	—	600	1.125	1.25	1.375
						0.55	500 Mbps ≤ D <sub>MAX</sub> ≤ 700 Mbps	1.8						

*continued...*

<sup>(18)</sup> V<sub>IN</sub> range: 0 V ≤ V<sub>IN</sub> ≤ 1.85 V.

<sup>(19)</sup> R<sub>L</sub> range: 90 ≤ R<sub>L</sub> ≤ 110 Ω.

<sup>(20)</sup> Low V<sub>OD</sub> setting is only supported for RSRS standard.

<sup>(21)</sup> LVPECL input standard is only supported at clock input. Output standard is not supported.



## Internal Oscillator Specifications

**Table 32. Internal Oscillator Frequencies for Intel MAX 10 Devices**

You can access to the internal oscillator frequencies in this table. The duty cycle of internal oscillator is approximately 45%–55%.

Device	Frequency			Unit
	Minimum	Typical	Maximum	
10M02	55	82	116	MHz
10M04				
10M08				
10M16				
10M25				
10M40	35	52	77	MHz
10M50				

## UFM Performance Specifications

**Table 33. UFM Performance Specifications for Intel MAX 10 Devices**

Block	Mode	Interface	Device	Frequency		Unit
				Minimum	Maximum	
UFM	Avalon®-MM slave	Parallel <sup>(33)</sup>	10M02 <sup>(34)</sup>	3.43	7.25	MHz
			10M04, 10M08, 10M16, 10M25, 10M40, 10M50	5	116	MHz
		Serial <sup>(34)</sup>	10M02, 10M04, 10M08, 10M16, 10M25	3.43	7.25	MHz
			10M40, 10M50	2.18	4.81	MHz

(33) Clock source is derived from user, except for 10M02 device.

(34) Clock source is derived from 1/16 of the frequency of the internal oscillator.



Parameter		Symbol	Condition	Min	Typ	Max	Unit
	Integral non linearity	INL	—	-2	—	2	LSB
AC Accuracy	Total harmonic distortion	THD	$F_{IN} = 50 \text{ kHz}$ , $F_S = 1 \text{ MHz}$ , PLL	-65 <sup>(37)</sup>	—	—	dB
	Signal-to-noise ratio	SNR	$F_{IN} = 50 \text{ kHz}$ , $F_S = 1 \text{ MHz}$ , PLL	54 <sup>(38)</sup>	—	—	dB
	Signal-to-noise and distortion	SINAD	$F_{IN} = 50 \text{ kHz}$ , $F_S = 1 \text{ MHz}$ , PLL	53 <sup>(39)</sup>	—	—	dB
On-Chip Temperature Sensor	Temperature sampling rate	$T_S$	—	—	—	50	kSPS
	Absolute accuracy	—	-40 to 125°C, with 64 samples averaging <sup>(40)</sup>	—	—	±10	°C
Conversion Rate <sup>(41)</sup>	Conversion time	—	Single measurement	—	—	1	Cycle
			Continuous measurement	—	—	1	Cycle
			Temperature measurement	—	—	1	Cycle

### Related Information

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(37) THD with prescalar enabled is 6dB less than the specification.

(38) SNR with prescalar enabled is 6dB less than the specification.

(39) SINAD with prescalar enabled is 6dB less than the specification.

(40) For the Intel Quartus Prime software version 15.0 and later, Modular ADC Core Intel FPGA IP and Modular Dual ADC Core Intel FPGA IP cores handle the 64 samples averaging. For the Intel Quartus Prime software versions prior to 14.1, you need to implement your own averaging calculation.

(41) For more detailed description, refer to the Timing section in the *Intel MAX 10 Analog-to-Digital Converter User Guide*.



## Dual Supply Devices ADC Performance Specifications

**Table 35.** ADC Performance Specifications for Intel MAX 10 Dual Supply Devices

Parameter	Symbol	Condition	Min	Typ	Max	Unit
ADC resolution	—	—	—	—	12	bits
Analog supply voltage	$V_{CCA\_ADC}$	—	2.375	2.5	2.625	V
Digital supply voltage	$V_{CCINT}$	—	1.15	1.2	1.25	V
External reference voltage	$V_{REF}$	—	$V_{CCA\_ADC} - 0.5$	—	$V_{CCA\_ADC}$	V
Sampling rate	$f_s$	Accumulative sampling rate	—	—	1	MSPS
Operating junction temperature range	$T_J$	—	-40	25	125	°C
Analog input voltage	$V_{IN}$	Prescalar disabled	0	—	$V_{REF}$	V
		Prescalar enabled <sup>(42)</sup>	0	—	3	V
Analog supply current (DC)	$I_{ACC\_ADC}$	Average current	—	275	450	µA
Digital supply current (DC)	$I_{CCINT}$	Average current	—	65	150	µA
Input resistance	$R_{IN}$	—	—	<sup>(43)</sup>	—	—
Input capacitance	$C_{IN}$	—	—	<sup>(43)</sup>	—	—
DC Accuracy	Offset error and drift	$E_{offset}$	Prescalar disabled	-0.2	—	%FS
			Prescalar enabled	-0.5	—	%FS
	Gain error and drift	$E_{gain}$	Prescalar disabled	-0.5	—	%FS
			Prescalar enabled	-0.75	—	%FS
Differential non linearity		$DNL$	External $V_{REF}$ , no missing code	-0.9	—	0.9 LSB

*continued...*

<sup>(42)</sup> Prescalar function divides the analog input voltage by half. The analog input handles up to 3 V input for the Intel MAX 10 dual supply devices.

<sup>(43)</sup> Download the SPICE models for simulation.



### True RSDS and Emulated RSDS\_E\_3R Transmitter Timing Specifications

#### Single Supply Devices True RSDS and Emulated RSDS\_E\_3R Transmitter Timing Specifications

**Table 37. True RSDS and Emulated RSDS\_E\_3R Transmitter Timing Specifications for Intel MAX 10 Single Supply Devices**

True **RSDS** transmitter is only supported at bottom I/O banks. Emulated **RSDS** transmitter is supported at the output pin of all I/O banks.

Symbol	Parameter	Mode	-I6, -A6, -C7, -I7			-A7			-C8			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
$f_{HSCLK}$	Input clock frequency (high-speed I/O performance pin)	×10	5	—	50	5	—	50	5	—	50	MHz
		×8	5	—	50	5	—	50	5	—	50	MHz
		×7	5	—	50	5	—	50	5	—	50	MHz
		×4	5	—	50	5	—	50	5	—	50	MHz
		×2	5	—	50	5	—	50	5	—	50	MHz
		×1	5	—	100	5	—	100	5	—	100	MHz
$HSIODR$	Data rate (high-speed I/O performance pin)	×10	100	—	100	100	—	100	100	—	100	Mbps
		×8	80	—	100	80	—	100	80	—	100	Mbps
		×7	70	—	100	70	—	100	70	—	100	Mbps
		×4	40	—	100	40	—	100	40	—	100	Mbps
		×2	20	—	100	20	—	100	20	—	100	Mbps
		×1	10	—	100	10	—	100	10	—	100	Mbps
$f_{HSCLK}$	Input clock frequency (low-speed I/O performance pin)	×10	5	—	50	5	—	50	5	—	50	MHz
		×8	5	—	50	5	—	50	5	—	50	MHz
		×7	5	—	50	5	—	50	5	—	50	MHz
		×4	5	—	50	5	—	50	5	—	50	MHz
		×2	5	—	50	5	—	50	5	—	50	MHz
		×1	5	—	100	5	—	100	5	—	100	MHz
HSIODR	Data rate (low-speed I/O performance pin)	×10	100	—	100	100	—	100	100	—	100	Mbps

*continued...*

## Dual Supply Devices True RSDS and Emulated RSDS\_E\_3R Transmitter Timing Specifications

**Table 38. True RSDS and Emulated RSDS\_E\_3R Transmitter Timing Specifications for Intel MAX 10 Dual Supply Devices**

True **RSDS** transmitter is only supported at bottom I/O banks. Emulated **RSDS** transmitter is supported at the output pin of all I/O banks.

Symbol	Parameter	Mode	-I6, -A6, -C7, -I7			-A7			-C8			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
$f_{HSCLK}$	Input clock frequency (high-speed I/O performance pin)	×10	5	—	155	5	—	155	5	—	155	MHz
		×8	5	—	155	5	—	155	5	—	155	MHz
		×7	5	—	155	5	—	155	5	—	155	MHz
		×4	5	—	155	5	—	155	5	—	155	MHz
		×2	5	—	155	5	—	155	5	—	155	MHz
		×1	5	—	310	5	—	310	5	—	310	MHz
HSIODR	Data rate (high-speed I/O performance pin)	×10	100	—	310	100	—	310	100	—	310	Mbps
		×8	80	—	310	80	—	310	80	—	310	Mbps
		×7	70	—	310	70	—	310	70	—	310	Mbps
		×4	40	—	310	40	—	310	40	—	310	Mbps
		×2	20	—	310	20	—	310	20	—	310	Mbps
		×1	10	—	310	10	—	310	10	—	310	Mbps
$f_{HSCLK}$	Input clock frequency (low-speed I/O performance pin)	×10	5	—	150	5	—	150	5	—	150	MHz
		×8	5	—	150	5	—	150	5	—	150	MHz
		×7	5	—	150	5	—	150	5	—	150	MHz
		×4	5	—	150	5	—	150	5	—	150	MHz
		×2	5	—	150	5	—	150	5	—	150	MHz
		×1	5	—	300	5	—	300	5	—	300	MHz
HSIODR	Data rate (low-speed I/O performance pin)	×10	100	—	300	100	—	300	100	—	300	Mbps
		×8	80	—	300	80	—	300	80	—	300	Mbps
		×7	70	—	300	70	—	300	70	—	300	Mbps

*continued...*

### True Mini-LVDS and Emulated Mini-LVDS\_E\_3R Transmitter Timing Specifications

**Table 40. True Mini-LVDS and Emulated Mini-LVDS\_E\_3R Transmitter Timing Specifications for Intel MAX 10 Dual Supply Devices**

True **mini-LVDS** transmitter is only supported at the bottom I/O banks. Emulated **mini-LVDS\_E\_3R** transmitter is supported at the output pin of all I/O banks.

Symbol	Parameter	Mode	-I6, -A6, -C7, -I7			-A7			-C8			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
$f_{HSCLK}$	Input clock frequency (high-speed I/O performance pin)	×10	5	—	155	5	—	155	5	—	155	MHz
		×8	5	—	155	5	—	155	5	—	155	MHz
		×7	5	—	155	5	—	155	5	—	155	MHz
		×4	5	—	155	5	—	155	5	—	155	MHz
		×2	5	—	155	5	—	155	5	—	155	MHz
		×1	5	—	310	5	—	310	5	—	310	MHz
HSIODR	Data rate (high-speed I/O performance pin)	×10	100	—	310	100	—	310	100	—	310	Mbps
		×8	80	—	310	80	—	310	80	—	310	Mbps
		×7	70	—	310	70	—	310	70	—	310	Mbps
		×4	40	—	310	40	—	310	40	—	310	Mbps
		×2	20	—	310	20	—	310	20	—	310	Mbps
		×1	10	—	310	10	—	310	10	—	310	Mbps
$f_{HSCLK}$	Input clock frequency (low-speed I/O performance pin)	×10	5	—	150	5	—	150	5	—	150	MHz
		×8	5	—	150	5	—	150	5	—	150	MHz
		×7	5	—	150	5	—	150	5	—	150	MHz
		×4	5	—	150	5	—	150	5	—	150	MHz
		×2	5	—	150	5	—	150	5	—	150	MHz
		×1	5	—	300	5	—	300	5	—	300	MHz
HSIODR	Data rate (low-speed I/O performance pin)	×10	100	—	300	100	—	300	100	—	300	Mbps
		×8	80	—	300	80	—	300	80	—	300	Mbps

*continued...*

Symbol	Parameter	Mode	-C7, -I7			-A7			-C8			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
		x8	80	—	200	80	—	200	80	—	200	Mbps
		x7	70	—	200	70	—	200	70	—	200	Mbps
		x4	40	—	200	40	—	200	40	—	200	Mbps
		x2	20	—	200	20	—	200	20	—	200	Mbps
		x1	10	—	200	10	—	200	10	—	200	Mbps
t <sub>DUTY</sub>	Duty cycle on transmitter output clock	—	45	—	55	45	—	55	45	—	55	%
TCCS <sup>(67)</sup>	Transmitter channel-to-channel skew	—	—	—	300	—	—	300	—	—	300	ps
t <sub>x Jitter</sub> <sup>(68)</sup>	Output jitter	—	—	—	1,000	—	—	1,000	—	—	1,000	ps
t <sub>RISE</sub>	Rise time	20 – 80%, C <sub>LOAD</sub> = 5 pF	—	500	—	—	500	—	—	500	—	ps
t <sub>FALL</sub>	Fall time	20 – 80%, C <sub>LOAD</sub> = 5 pF	—	500	—	—	500	—	—	500	—	ps
t <sub>LOCK</sub>	Time required for the PLL to lock, after CONF_DONE signal goes high, indicating the completion of device configuration	—	—	—	1	—	—	1	—	—	1	ms

(67) TCCS specifications apply to I/O banks from the same side only.

(68) TX jitter is the jitter induced from core noise and I/O switching noise.



## Dual Supply Devices Emulated LVDS\_E\_3R, SLVS, and Sub-LVDS Transmitter Timing Specifications

**Table 44. Emulated LVDS\_E\_3R, SLVS, and Sub-LVDS Transmitter Timing Specifications for Intel MAX 10 Dual Supply Devices**

Emulated **LVDS\_E\_3R**, **SLVS**, and **Sub-LVDS** transmitters are supported at the output pin of all I/O banks.

Symbol	Parameter	Mode	-I6, -A6, -C7, -I7			-A7			-C8			Unit
			Min	Typ	Max	Min	Typ	Max	Min	Typ	Max	
$f_{HSCLK}$	Input clock frequency (high-speed I/O performance pin)	×10	5	—	300	5	—	275	5	—	275	MHz
		×8	5	—	300	5	—	275	5	—	275	MHz
		×7	5	—	300	5	—	275	5	—	275	MHz
		×4	5	—	300	5	—	275	5	—	275	MHz
		×2	5	—	300	5	—	275	5	—	275	MHz
		×1	5	—	300	5	—	275	5	—	275	MHz
HSIODR	Data rate (high-speed I/O performance pin)	×10	100	—	600	100	—	550	100	—	550	Mbps
		×8	80	—	600	80	—	550	80	—	550	Mbps
		×7	70	—	600	70	—	550	70	—	550	Mbps
		×4	40	—	600	40	—	550	40	—	550	Mbps
		×2	20	—	600	20	—	550	20	—	550	Mbps
		×1	10	—	300	10	—	275	10	—	275	Mbps
$f_{HSCLK}$	Input clock frequency (low-speed I/O performance pin)	×10	5	—	150	5	—	150	5	—	150	MHz
		×8	5	—	150	5	—	150	5	—	150	MHz
		×7	5	—	150	5	—	150	5	—	150	MHz
		×4	5	—	150	5	—	150	5	—	150	MHz
		×2	5	—	150	5	—	150	5	—	150	MHz
		×1	5	—	300	5	—	300	5	—	300	MHz
HSIODR	Data rate (low-speed I/O performance pin)	×10	100	—	300	100	—	300	100	—	300	Mbps
		×8	80	—	300	80	—	300	80	—	300	Mbps

*continued...*

## JTAG Timing Parameters

**Table 49. JTAG Timing Parameters for Intel MAX 10 Devices**

The values are based on  $C_L = 10 \text{ pF}$  of TDO.

The affected Boundary Scan Test (BST) instructions are SAMPLE/PRELOAD, EXTEST, INTEST, and CHECK\_STATUS.

Symbol	Parameter	Non-BST and non-CONFIG_IO Operation		BST and CONFIG_IO Operation		Unit
		Minimum	Maximum	Minimum	Maximum	
$t_{JCP}$	TCK clock period	40	—	50	—	ns
$t_{JCH}$	TCK clock high time	20	—	25	—	ns
$t_{JCL}$	TCK clock low time	20	—	25	—	ns
$t_{JPSU\_TDI}$	JTAG port setup time	2	—	2	—	ns
$t_{JPSU\_TMS}$	JTAG port setup time	3	—	3	—	ns
$t_{JPH}$	JTAG port hold time	10	—	10	—	ns
$t_{JPCO}$	JTAG port clock to output	—	<ul style="list-style-type: none"> <li>15 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>17 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	—	<ul style="list-style-type: none"> <li>18 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>20 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	ns
$t_{JPZX}$	JTAG port high impedance to valid output	—	<ul style="list-style-type: none"> <li>15 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>17 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	—	<ul style="list-style-type: none"> <li>15 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>17 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	ns
$t_{JPXZ}$	JTAG port valid output to high impedance	—	<ul style="list-style-type: none"> <li>15 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>17 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	—	<ul style="list-style-type: none"> <li>15 (for <math>V_{CCIO} = 3.3, 3.0,</math> and 2.5 V)</li> <li>17 (for <math>V_{CCIO} = 1.8</math> and 1.5 V)</li> </ul>	ns



Device	CFM Data Size (bits)	
	Without Memory Initialization	With Memory Initialization
10M25	4,140,000	4,780,000
10M40	7,840,000	9,670,000
10M50	7,840,000	9,670,000

## Internal Configuration Time

The internal configuration time measurement is from the rising edge of nSTATUS signal to the rising edge of CONF\_DONE signal.

**Table 53. Internal Configuration Time for Intel MAX 10 Devices (Uncompressed .rbf)**

Device	Internal Configuration Time (ms)							
	Unencrypted				Encrypted			
	Without Memory Initialization		With Memory Initialization		Without Memory Initialization		With Memory Initialization	
	Min	Max	Min	Max	Min	Max	Min	Max
10M02	0.3	1.7	—	—	1.7	5.4	—	—
10M04	0.6	2.7	1.0	3.4	5.0	15.0	6.8	19.6
10M08	0.6	2.7	1.0	3.4	5.0	15.0	6.8	19.6
10M16	1.1	3.7	1.4	4.5	9.3	25.3	11.7	31.5
10M25	1.0	3.7	1.3	4.4	14.0	38.1	16.9	45.7
10M40	2.6	6.9	3.2	9.8	41.5	112.1	51.7	139.6
10M50	2.6	6.9	3.2	9.8	41.5	112.1	51.7	139.6



## Programmable IOE Delay for Column Pins

**Table 58.** IOE Programmable Delay on Column Pins for Intel MAX 10 Devices

The incremental values for the settings are generally linear. For exact values of each setting, refer to the **Assignment Name** column in the latest version of the Intel Quartus Prime software.

The minimum and maximum offset timing numbers are in reference to setting '0' as available in the Intel Quartus Prime software.

Parameter	Paths Affected	Number of Settings	Minimum Offset	Maximum Offset							Unit	
				Fast Corner		Slow Corner						
				-I7	-C8	-A6	-C7	-C8	-I7	-A7		
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	0.81	0.868	1.823	1.802	1.864	1.862	1.912	ns	
Input delay from pin to input register	Pad to I/O input register	8	0	0.914	0.981	2.06	2.032	2.101	2.102	2.161	ns	
Delay from output register to output pin	I/O output register to pad	2	0	0.435	0.466	0.971	0.97	1.013	1.001	1.028	ns	

## Glossary

**Table 59. Glossary**

Term	Definition
JTAG Timing Specifications	
$R_L$	Receiver differential input discrete resistor (external to Intel MAX 10 devices).
RSKM (Receiver input skew margin)	HIGH-SPEED I/O block: The total margin left after accounting for the sampling window and TCCS. RSKM = (TUI - SW - TCCS) / 2.
Sampling window (SW)	HIGH-SPEED I/O Block: The period of time during which the data must be valid to capture it correctly. The setup and hold times determine the ideal strobe position in the sampling window.
Single-ended voltage referenced I/O standard	The AC input signal values indicate the voltage levels at which the receiver must meet its timing specifications. The DC input signal values indicate the voltage levels at which the final logic state of the receiver is unambiguously defined. After the receiver input crosses the AC value, the receiver changes to the new logic state. The new logic state is then maintained as long as the input stays beyond the DC threshold. This approach is intended to provide predictable receiver timing in the presence of input waveform ringing.
$t_c$	High-speed receiver/transmitter input and output clock period.
TCCS (Channel-to- channel-skew)	HIGH-SPEED I/O block: The timing difference between the fastest and slowest output edges, including $t_{co}$ variation and clock skew. The clock is included in the TCCS measurement.
$t_{cin}$	Delay from clock pad to I/O input register.
$t_{co}$	Delay from clock pad to I/O output.
$t_{cout}$	Delay from clock pad to I/O output register.

*continued...*